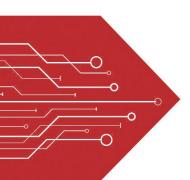
# MSKSEMI















**ESD** 

TVS

TSS

MOV

**GDT** 

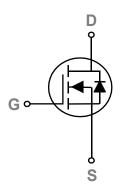
**PLED** 

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SOT-723



#### **Features**

- $60V,200mA, RDS(ON) = 1.7\Omega@VGS = 10V$
- Fast switching
- Green Device Available

#### **Applications**

- Notebook
- Smartphone
- Battery Protection
- Hand-held Instruments

BVDSS	RDSON	ID
60V	1.7Ω	200mA

#### **Absolute Maximum Ratings** Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	60	V
V <sub>G</sub> S	Gate-Source Voltage	±20	V
I_	Drain Current – Continuous (T <sub>A</sub> =25°C)	200	mA
ID	Drain Current – Continuous (T <sub>A</sub> =70°C)	160	mA
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	800	mA
D-	Power Dissipation (T <sub>A</sub> =25°C)	156	mW
PD	Power Dissipation – Derate above 25°C	1.25	mW/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		800	°C/W



#### **Electrical Characteristics** (T<sub>J</sub>=25 °C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	60			V
I	Drain Sauras Laskaga Current	V <sub>DS</sub> =60V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			10	nA
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			100	nA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA

#### **On Characteristics**

R <sub>DS(ON)</sub> Static Drain-Source On-Resistance		V <sub>GS</sub> =10V , I <sub>D</sub> =0.15A		1.6 3	3	
		V <sub>GS</sub> =4.5V , I <sub>D</sub> =0.1A		1.7	4	Ω
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250uA$	1.0	2	3.0	V
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =0.1A		0.3		S

#### **Dynamic and switching Characteristics**

•				
$Q_g$	Total Gate Charge <sup>2, 3</sup>		 2	
$Q_{gs}$	Gate-Source Charge <sup>2, 3</sup>	V <sub>DS</sub> =30V , V <sub>GS</sub> =10V , I <sub>D</sub> =0.1A	 0.9	nC
$Q_{gd}$	Gate-Drain Charge <sup>2, 3</sup>		 0.4	
T <sub>d(on)</sub>	Turn-On Delay Time <sup>2, 3</sup>		 3	
Tr	Rise Time <sup>2, 3</sup>	$V_{DD}$ =30V , $V_{GS}$ =10V , $R_{G}$ =6 $\Omega$	 5	no
T <sub>d(off)</sub>	Turn-Off Delay Time <sup>2, 3</sup>	I <sub>D</sub> =0.1A	 14	ns
Tf	Fall Time <sup>2, 3</sup>		 9	
Ciss	Input Capacitance		 25	
Coss	Output Capacitance	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , F=1MHz	 15	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		 6.8	

#### **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	VV			200	mA
Isм	Pulsed Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			400	mA
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =0.1A , T <sub>J</sub> =25°C			1	V
Trr	Reverse Recovery Time	VR=50V, Is=0.1A,		18		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dl/dt=100A/µs, Tյ=25°ℂ		6		nC

#### Note

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 3. Essentially independent of operating temperature.



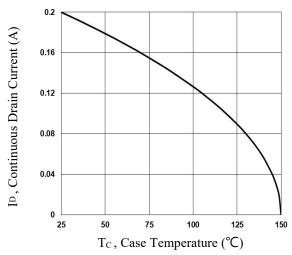


Fig.1 Continuous Drain Current vs.  $T_c$ 

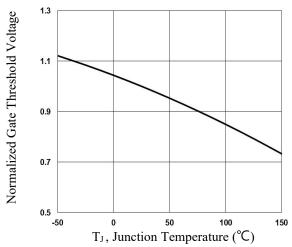


Fig.3 Normalized Vth vs. TJ

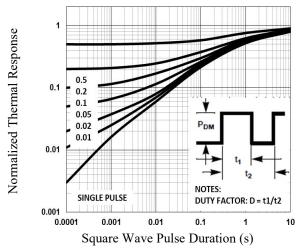


Fig.5 Normalized Transient Response

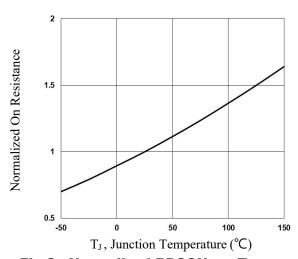


Fig.2 Normalized RDSON vs. T<sub>J</sub>

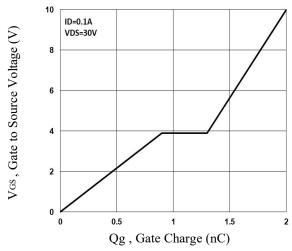


Fig.4 Gate Charge Waveform

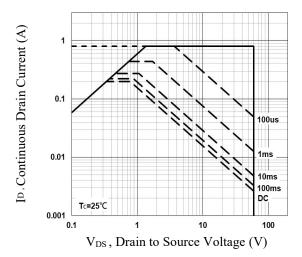
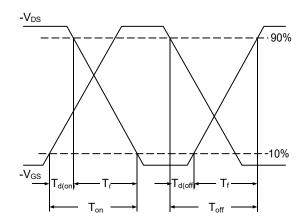


Fig.6 Maximum Safe Operation Area





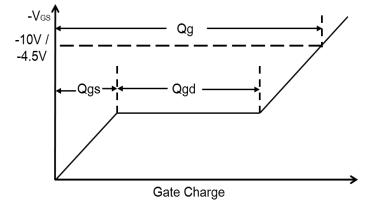
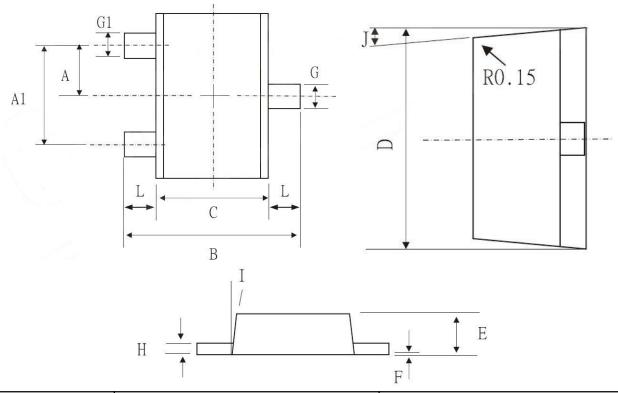


Fig.7 Switching Time Waveform

Fig.8 Gate Charge Waveform



## **SOT-723 PACKAGE INFORMATION**



Symbol	Dimensions I	n Millimeters	Dimension	s In Inches
	MAX	MIN	MAX	MIN
A	0.4	BSC	0.01	6BSC
A1	0.8	BSC	0.03	1BSC
В	1.250	1.150	0.049	0.045
С	0.850	0.750	0.033	0.030
D	1.250	1.150	0.049	0.045
E	0.390	0.370	0.015	0.015
F	0.050	0.000	0.002	0.000
G	0.270	0.220	0.011	0.009
G1	0.220	0.170	0.009	0.007
Н	0.110	0.009	0.004	0.000
I	13°	9°	13°	9°
L	0.250	0.150	0.010	0.006
J	11°	7°	11°	7°

#### **REEL SPECIFICATION**

P/N	PKG	QTY
2N7002KM	SOT-723	8000





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